

P-Channel 20 V (D-S) MOSFET with Schottky Diode

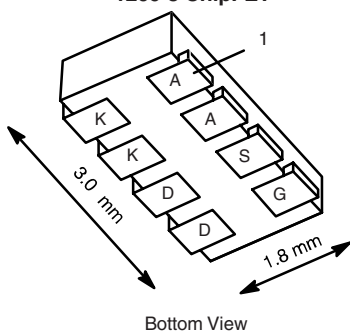
MOSFET PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)	Q_g (Typ.)
- 20	0.104 at $V_{GS} = -4.5$ V	- 4 ^a	4.2 nC
	0.144 at $V_{GS} = -2.5$ V	- 3.6	
	0.205 at $V_{GS} = -1.8$ V	- 3	

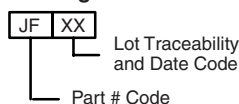
SCHOTTKY PRODUCT SUMMARY

V_{KA} (V)	V_f (V) Diode Forward Voltage	I_F (A)
20	0.46 at 0.5 A	1

1206-8 ChipFET



Marking Code



FEATURES

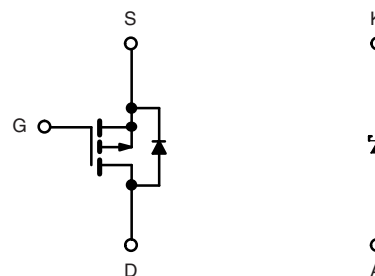
- Halogen-free According to IEC 61249-2-21 Definition
- LITTLE FOOT® Plus Schottky Power MOSFET
- Compliant to RoHS Directive 2002/95/EC



RoHS
COMPLIANT
HALOGEN
FREE
Available

APPLICATIONS

- Charging Switch for Portable Devices
- With Integrated Low V_f Trench Schottky Diode



P-Channel MOSFET

Ordering Information: Si5853CDC-T1-E3 (Lead (Pb)-free)
Si5853CDC-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter		Symbol	Limit	Unit
Drain-Source Voltage (MOSFET)		V _{DS}	- 20	V
Reverse Voltage (Schottky)		V _{KA}	20	
Gate-Source Voltage (MOSFET)		V _{GS}	± 8	
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _C = 25 °C	I _D	- 4 ^a	A
	T _C = 70 °C		- 3.4 ^a	
	T _A = 25 °C		- 2.9 ^{b, c}	
	T _A = 70 °C		- 2.3 ^{b, c}	
Pulsed Drain Current (MOSFET)		I _{DM}	- 10	
Continuous Source Current (MOSFET Diode Conduction)	T _C = 25 °C	I _S	- 2.6	
	T _A = 25 °C		- 1.2 ^{b, c}	
Average Forward Current (Schottky)		I _F	1	
Pulsed Forward Current (Schottky)		I _{FM}	3	
Maximum Power Dissipation (MOSFET)	T _C = 25 °C	P _D	3.1	W
	T _C = 70 °C		2	
	T _A = 25 °C		1.5 ^{b, c}	
	T _A = 70 °C		0.9 ^{b, c}	
Maximum Power Dissipation (Schottky)	T _C = 25 °C		2.5	
	T _C = 70 °C		1.6	
	T _A = 25 °C		1.2	
	T _A = 70 °C		0.76	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendation (Peak Temperature) ^{d, e}			260	

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient (MOSFET) ^{b, c, f}	R_{thJA}	70	85	°C/W
Maximum Junction-to-Foot (Drain) (MOSFET)	R_{thJF}	33	40	
Maximum Junction-to-Ambient (Schottky) ^{b, c, g}	R_{thJA}	85	105	
Maximum Junction-to-Foot (Drain) (Schottky)	R_{thJF}	40	50	

Notes:

- Package limited.
- Surface mounted on FR4 board.
- $t \leq 5$ s.
- See Solder Profile (www.vishay.com/doc?73257). The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under steady state conditions for MOSFETs is 120 °C/W.
- Maximum under steady state conditions for Schottky is 125 °C/W.

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$	- 20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250\text{ }\mu\text{A}$		- 20		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			2.1		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$	- 0.45		- 1	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 8\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20\text{ V}, V_{GS} = 0\text{ V}$			- 1	μA
		$V_{DS} = -20\text{ V}, V_{GS} = 0\text{ V}, T_J = 85^\circ\text{C}$			- 10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \leq -5\text{ V}, V_{GS} = -4.5\text{ V}$	- 10			A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = -4.5\text{ V}, I_D = -2.5\text{ A}$		0.086	0.104	Ω
		$V_{GS} = -2.5\text{ V}, I_D = -2.1\text{ A}$		0.120	0.144	
		$V_{GS} = -1.8\text{ V}, I_D = -0.5\text{ A}$		0.170	0.205	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10\text{ V}, I_D = -2.5\text{ A}$		6		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		350		pF
Output Capacitance	C_{oss}			65		
Reverse Transfer Capacitance	C_{rss}			45		
Total Gate Charge	Q_g	$V_{DS} = -10\text{ V}, V_{GS} = -8\text{ V}, I_D = -2.9\text{ A}$		7.2	11	nC
		$V_{DS} = -10\text{ V}, V_{GS} = -4.5\text{ V}, I_D = -2.9\text{ A}$		4.2	6.5	
Gate-Source Charge	Q_{gs}			0.7		
Gate-Drain Charge	Q_{gd}			1		
Gate Resistance	R_g	$f = 1\text{ MHz}$		6.2		Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10\text{ V}, R_L = 4.4\text{ }\Omega$ $I_D \cong -2.3\text{ A}, V_{GEN} = -4.5\text{ V}, R_g = 1\text{ }\Omega$		15	25	ns
Rise Time	t_r			42	65	
Turn-Off Delay Time	$t_{d(off)}$			20	30	
Fall Time	t_f			10	15	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10\text{ V}, R_L = 4.4\text{ }\Omega$ $I_D \cong -2.3\text{ A}, V_{GEN} = -8\text{ V}, R_g = 1\text{ }\Omega$		5	10	
Rise Time	t_r			15	25	
Turn-Off Delay Time	$t_{d(off)}$			20	30	
Fall Time	t_f			10	15	

SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^{\circ}\text{C}$			- 2.6	A
Pulse Diode Forward Current	I_{SM}				- 10	
Body Diode Voltage	V_{SD}	$I_S = - 2.3\text{ A}$, $V_{GS} = 0\text{ V}$		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = - 2.3\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$ $T_J = 25\text{ }^{\circ}\text{C}$		20	40	ns
Body Diode Reverse Recovery Charge	Q_{rr}			15	30	nC
Reverse Recovery Fall Time	t_a			16		ns
Reverse Recovery Rise Time	t_b			4		

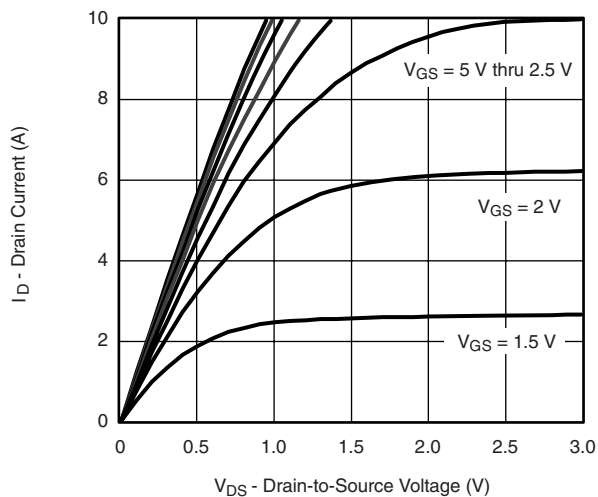
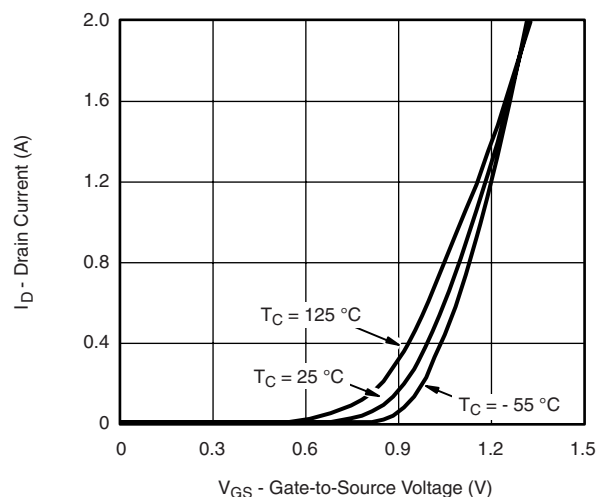
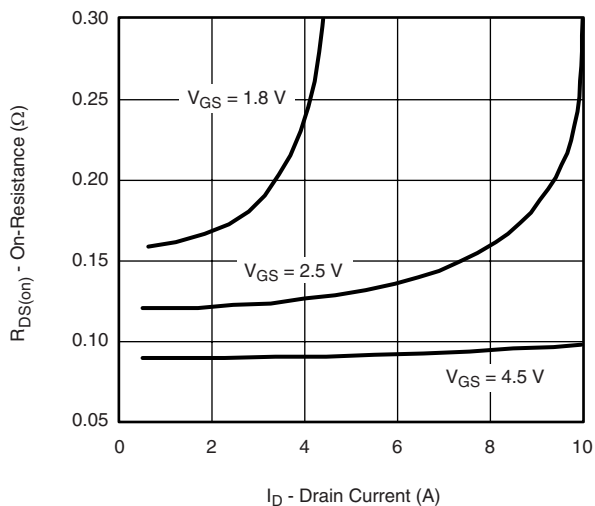
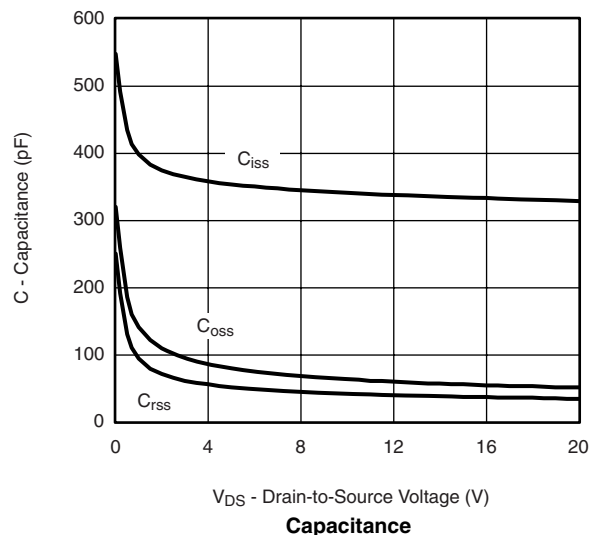
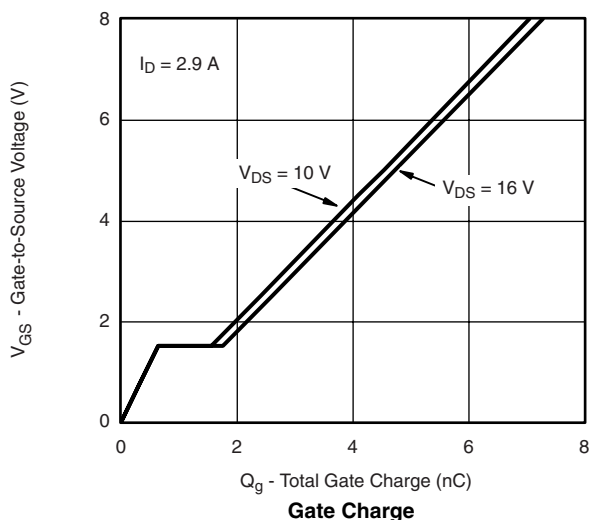
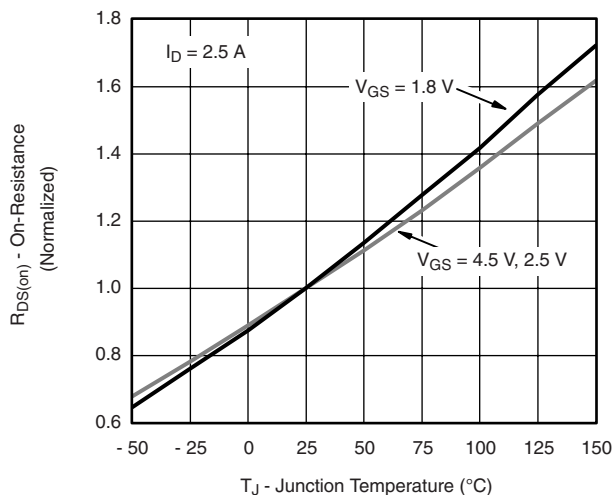
Notes:

a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

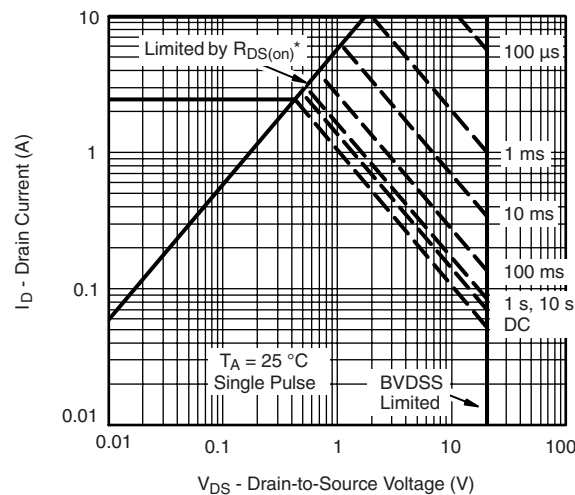
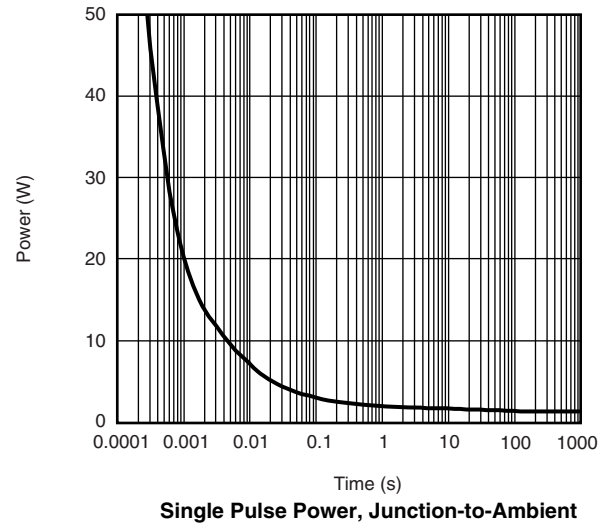
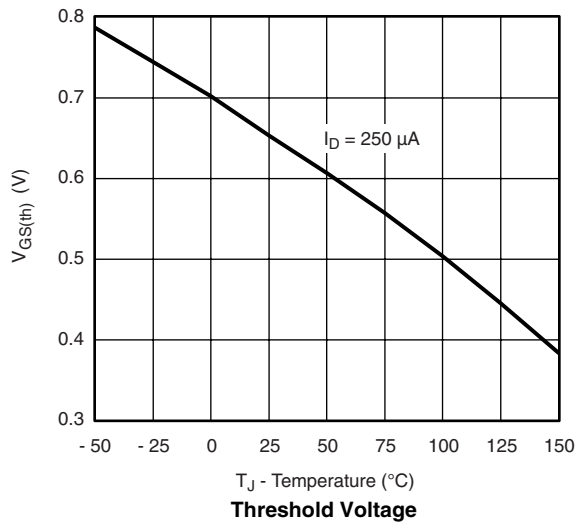
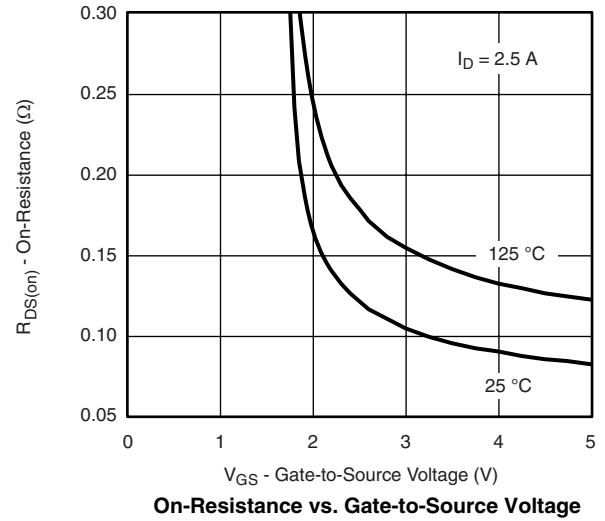
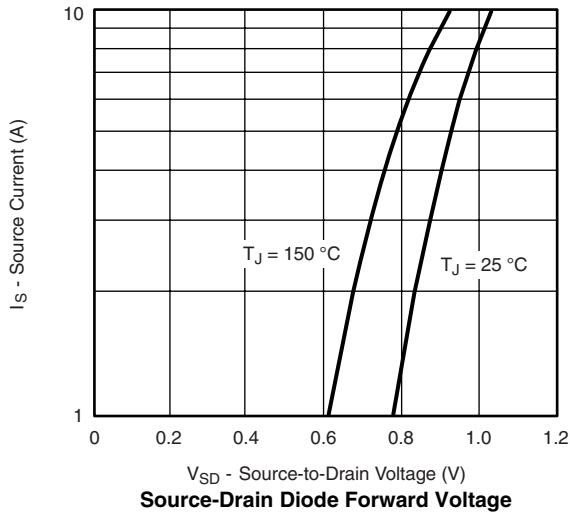
b. Guaranteed by design, not subject to production testing.

SCHOTTKY SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	V_F	$I_F = 0.5\text{ A}$		0.381	0.46	V
		$I_F = 1\text{ A}$		0.468	0.560	
		$I_F = 1\text{ A}$, $T_J = 125\text{ }^{\circ}\text{C}$		0.44	0.53	
Maximum Reverse Leakage Current	I_{rm}	$V_r = 5\text{ V}$		0.0081	0.080	mA
		$V_r = 5\text{ V}$, $T_J = 85\text{ }^{\circ}\text{C}$		0.4	4	
		$V_r = 5\text{ V}$, $T_J = 125\text{ }^{\circ}\text{C}$		2.8	28	
		$V_r = 20\text{ V}$		0.0093	0.09	
		$V_r = 20\text{ V}$, $T_J = 85\text{ }^{\circ}\text{C}$		0.45	4.5	
		$V_r = 20\text{ V}$, $T_J = 125\text{ }^{\circ}\text{C}$		3.2	32	
Junction Capacitance	C_T	$V_r = 10\text{ V}$		30		pF

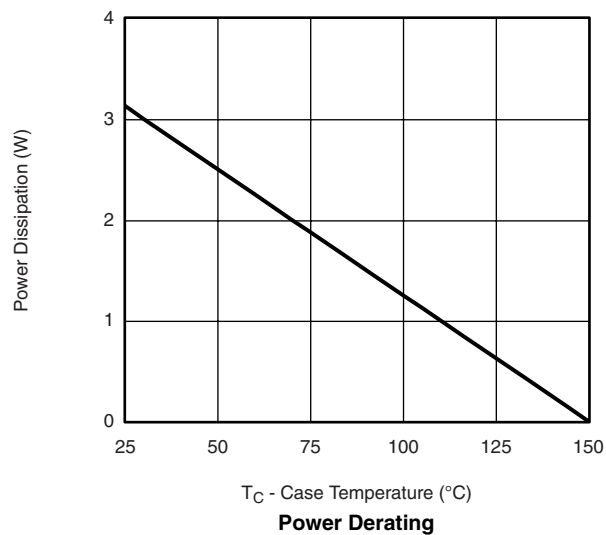
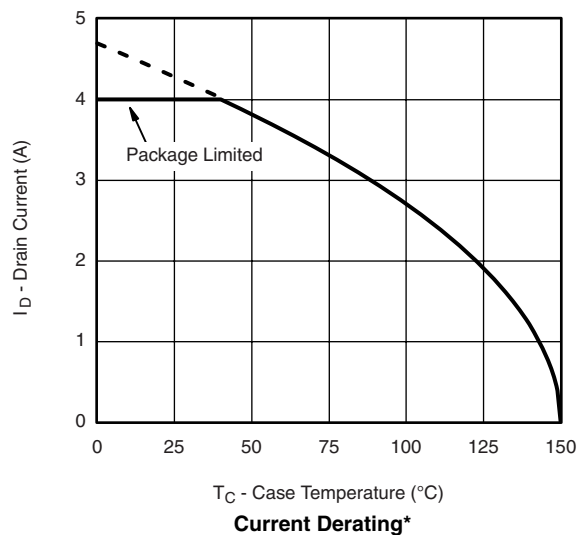
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**Output Characteristics****Transfer Characteristics****On-Resistance vs. Drain Current and Gate Voltage****Capacitance****Gate Charge****On-Resistance vs. Junction Temperature**

MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

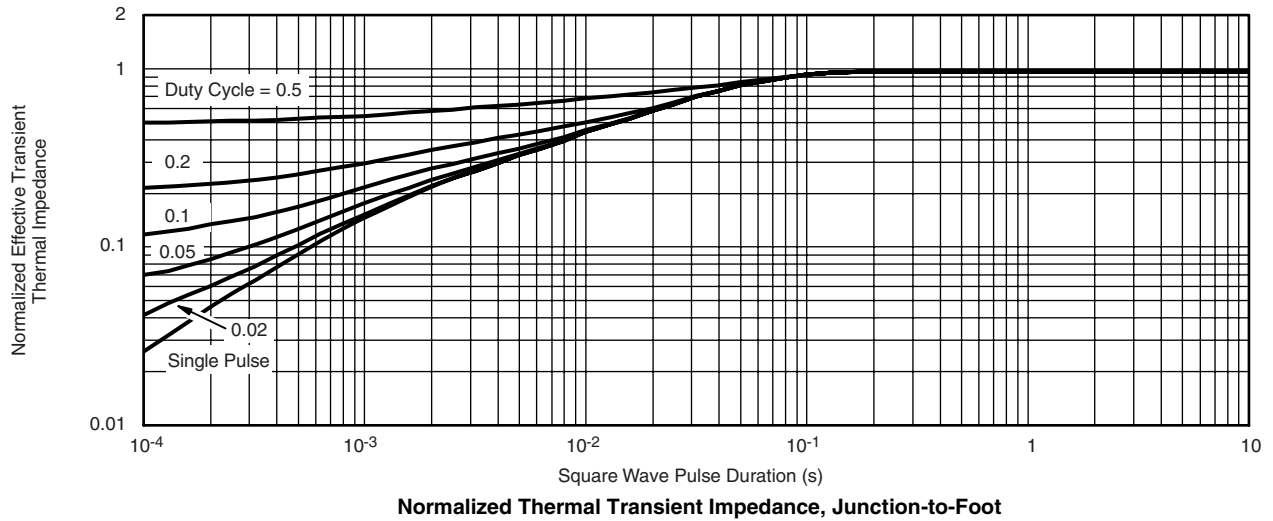
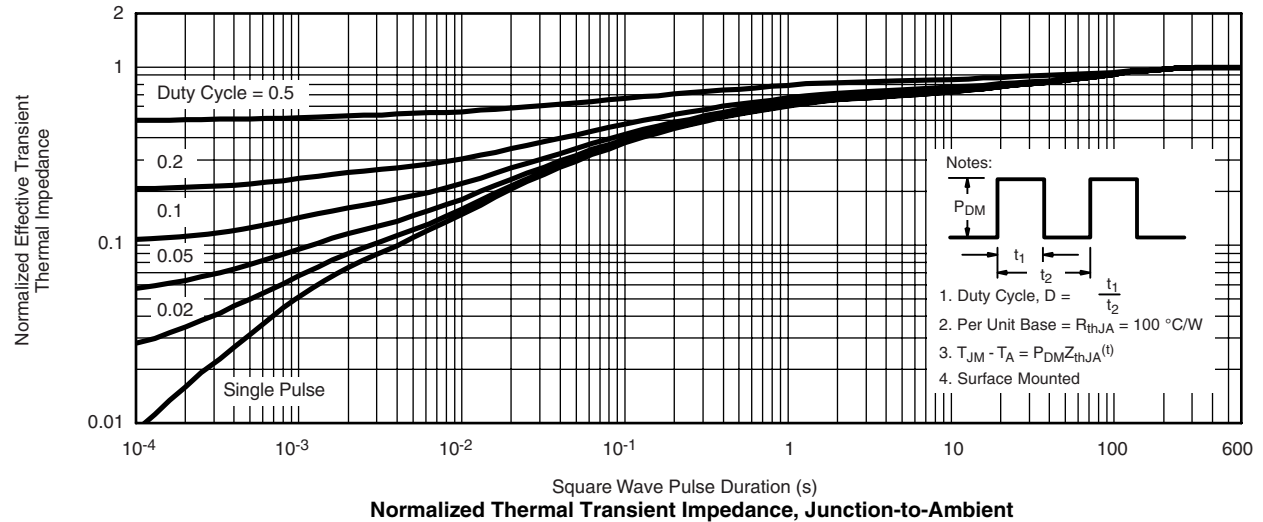


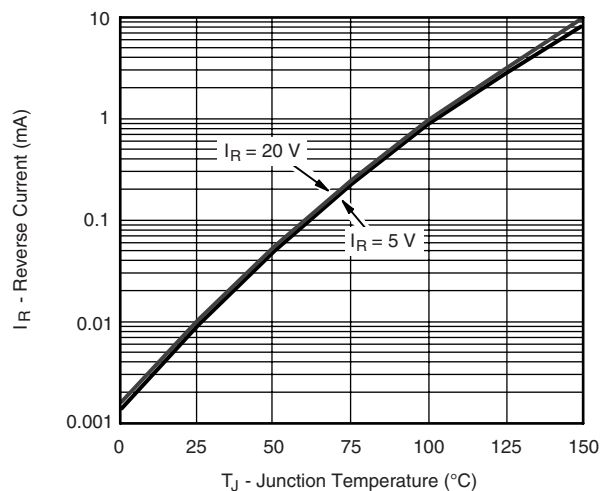
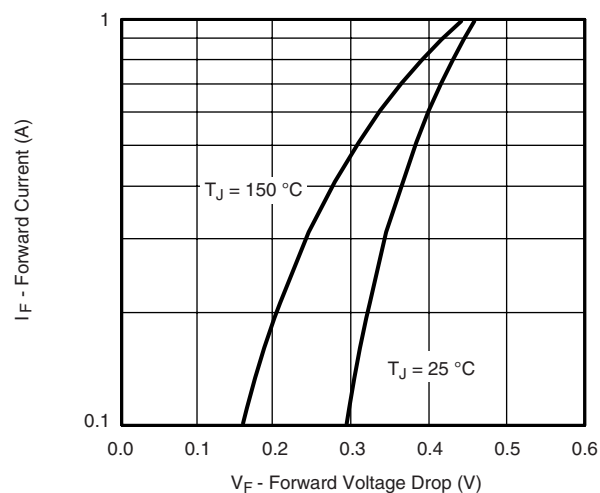
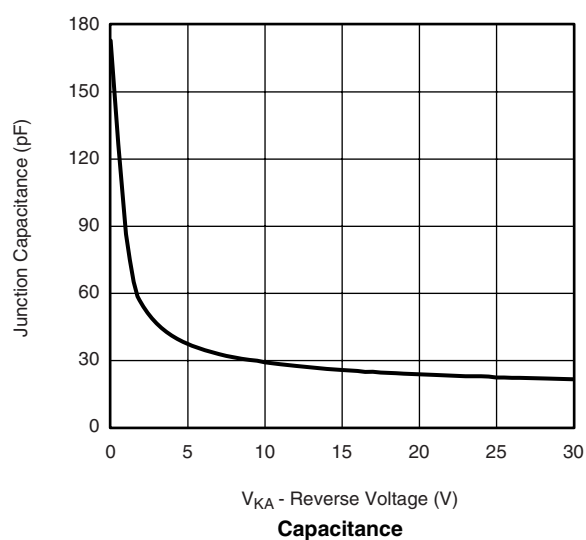
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient

MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

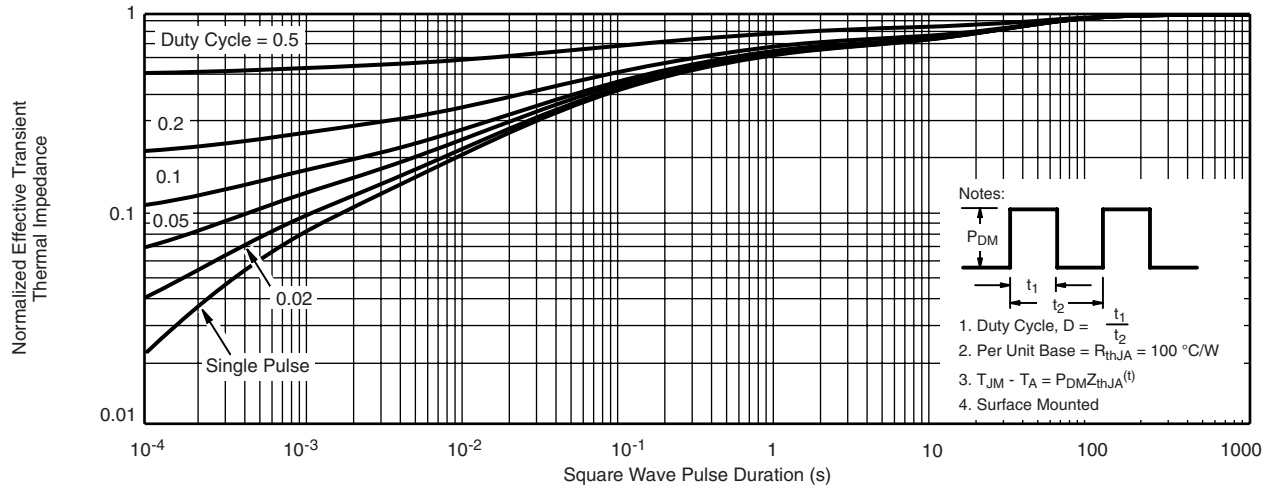
* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

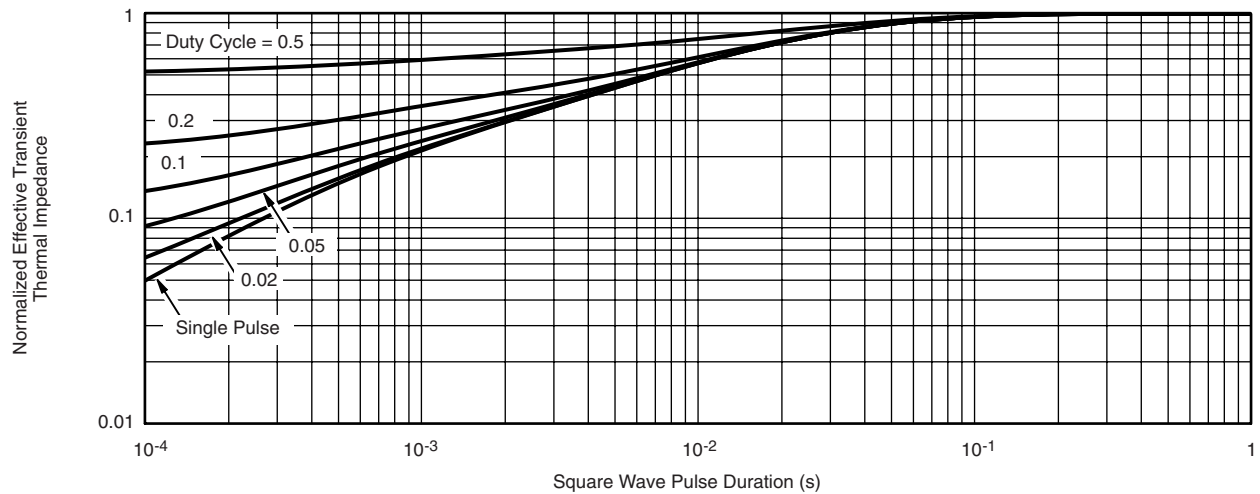


SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**Reverse Current vs. Junction Temperature****Forward Voltage Drop****Capacitance**

SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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